DATA SHEET



SWITCHING P-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The 2SJ605 is P-channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

*

- Super low on-state resistance: $R_{DS(on)1} = 20 \text{ m}\Omega \text{ MAX.}$ (VGs = -10 V, ID = -33 A) $R_{DS(on)2} = 31 \text{ m}\Omega \text{ MAX.}$ (VGs = -4.0 V, ID = -33 A)
- Low input capacitance
 - $C_{iss} = 4600 \text{ pF TYP}. (V_{DS} = -10 \text{ V}, \text{ V}_{GS} = 0 \text{ A})$
 - Built-in gate protection diode

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage ($V_{GS} = 0 V$)	Vdss	-60	V
Gate to Source Voltage ($V_{DS} = 0 V$)	Vgss	∓ 20	V
Drain Current (DC) (Tc = 25°C)	D(DC)	∓ 65	А
Drain Current (pulse) Note1	D(pulse)	∓ 200	А
Total Power Dissipation (Tc = 25°C)	Р⊤	100	W
Total Power Dissipation ($T_A = 25^{\circ}C$)	Р⊤	1.5	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	–55 to +150	°C
Single Avalanche Current Note2	las	-45	А
Single Avalanche Energy ^{Note2}	Eas	203	mJ

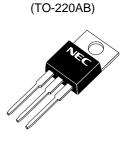
Notes 1. PW \leq 10 μ s, Duty cycle \leq 1%

2. Starting $T_{ch} = 25^{\circ}C$, $V_{DD} = -30$ V, $R_G = 25 \Omega$, $V_{GS} = -20 \rightarrow 0$ V

ORDERING INFORMATION

P	
PART NUMBER	PACKAGE
2SJ605	TO-220AB
2SJ605-S	TO-262
2SJ605-ZJ	TO-263
2SJ605-Z	TO-220SMD ^{Note}

Note TO-220SMD package is produced only in Japan.



(TO-262)



(TO-263, TO-220SMD)



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The mark **★** shows major revised points.

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ELECTRICAL CHARACTERISTICS (TA = 25°C)

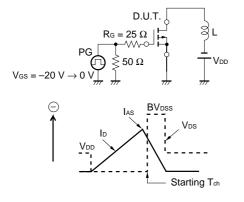
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	CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
	Zero Gate Voltage Drain Current	IDSS	$V_{DS} = -60 V, V_{GS} = 0 V$			-10	μA
	Gate Leakage Current	lgss	$V_{GS} = \mp 20 V$, $V_{DS} = 0 V$			∓ 10	μA
*	Gate Cut-off Voltage	V _{GS(off)}	$V_{DS} = -10 V$, $I_D = -1 mA$	-1.5	-2.0	-2.5	V
	Forward Transfer Admittance	y _{fs}	$V_{DS} = -10 V$, $I_D = -33 A$	30	59		S
	Drain to Source On-state Resistance	RDS(on)1	$V_{GS} = -10 \text{ V}, \text{ I}_D = -33 \text{ A}$		17	20	mΩ
		RDS(on)2	V _{GS} = -4.0 V, I _D = -33 A		22	31	mΩ
	Input Capacitance	Ciss	V _{DS} = -10 V		4600		pF
	Output Capacitance	Coss	V _{GS} = 0 V		820		pF
	Reverse Transfer Capacitance	Crss	f = 1 MHz		330		pF
*	Turn-on Delay Time	td(on)	$V_{DD} = -30 \text{ V}, \text{ Id} = -33 \text{ A}$		15		ns
	Rise Time	tr	V _{GS} = -10 V		14		ns
	Turn-off Delay Time	td(off)	$R_G = 0 \Omega$		100		ns
	Fall Time	tr			58		ns
	Total Gate Charge	QG	V _{DD} = -48 V		87		nC
	Gate to Source Charge	QGS	V _{GS} = -10 V		15		nC
	Gate to Drain Charge	Qgd	I⊳ = –65 A		22		nC
*	Body Diode Forward Voltage	VF(S-D)	IF = 65 A, VGS = 0 V		1.0		V
*	Reverse Recovery Time	trr	IF = 65 A, VGS = 0 V		53		ns
*	Reverse Recovery Charge	Qrr	di/dt = 100 A / μs		110		nC

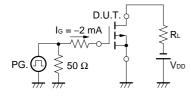
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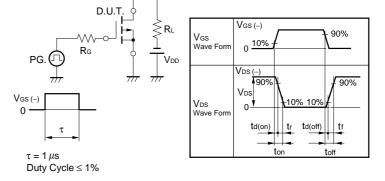
TEST CIRCUIT 1 AVALANCHE CAPABILITY

TEST CIRCUIT 2 SWITCHING TIME



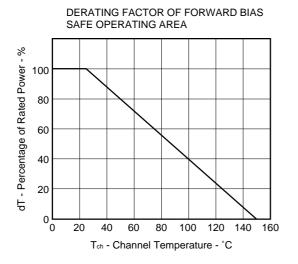
TEST CIRCUIT 3 GATE CHARGE

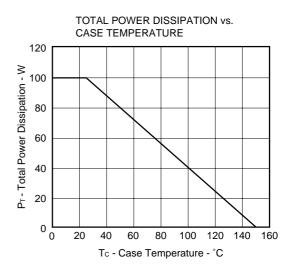




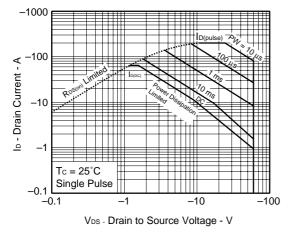
***** TYPICAL CHARACTERISTICS (TA = 25°C)

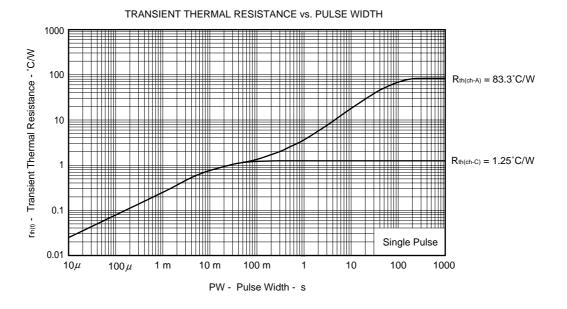
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FORWARD BIAS SAFE OPERATING AREA





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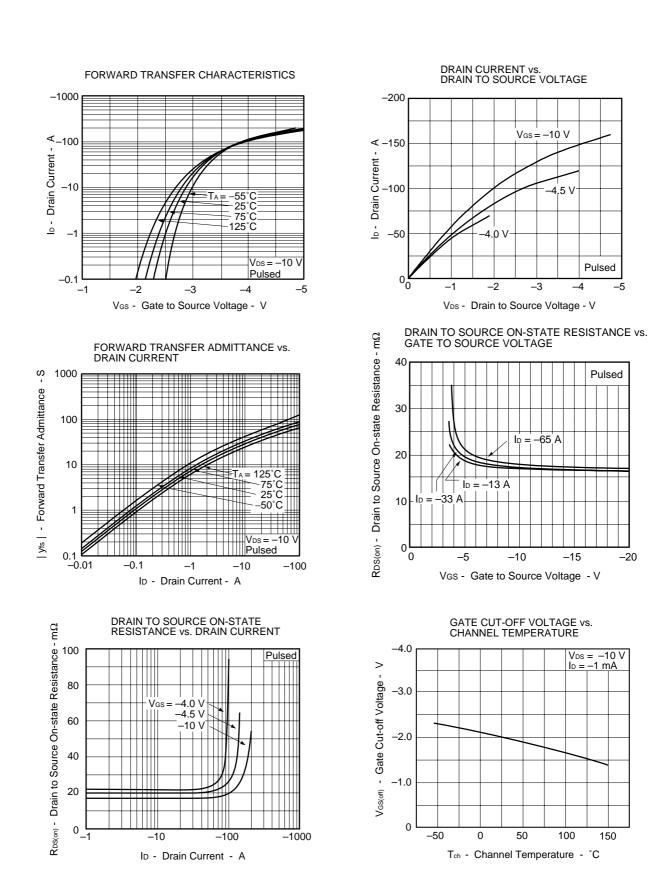
Pulsed

Pulsed

-20

150

-5

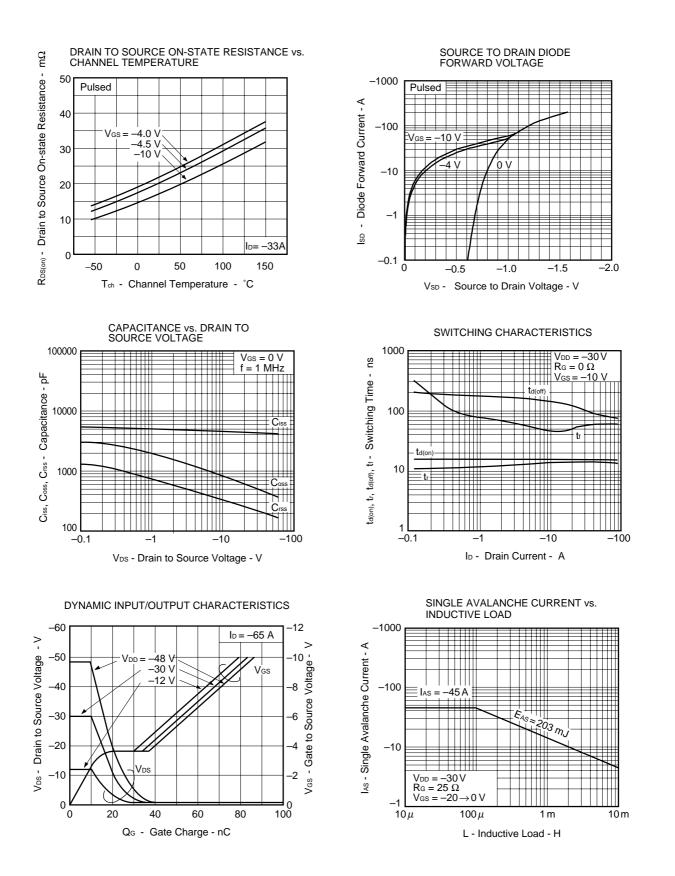


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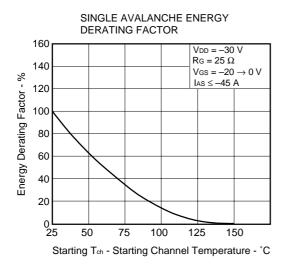
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2SJ605

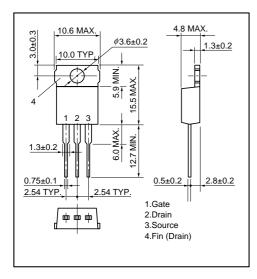


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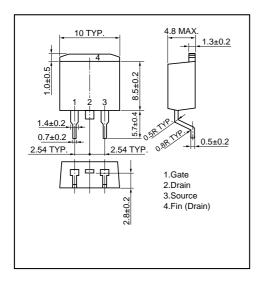
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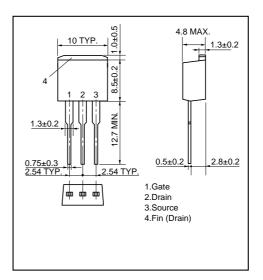
- PACKAGE DRAWINGS(Unit: mm)
 - 1) TO-220AB(MP-25)



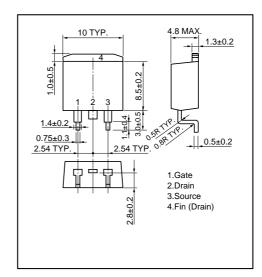
3) TO-263 (MP-25ZJ)



2) TO-262(MP-25 Fin Cut)

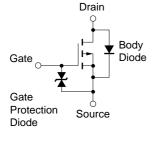


4) TO-220SMD(MP-25Z)^{Note}



Note This package is produced only in Japan.

EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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